

Search Notes



Application/Control No.

10/092,560

Examiner

Mark K. Han

Applicant(s)/Patent under Reexamination

BLANCO, ERNESTO E.

Art Unit

3767

SEARCHED

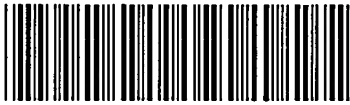
Class	Subclass	Date	Examiner
604	22 93.01	7/23/2006	mbh
	164.01		
	164.02		
	164.03		
	164.05		
	164.06		
	164.07		
	164.08		
	164.12		
	167.01		
	167.02		
	167.03		
	167.04		
	170.01		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Inventor name search	5/16/2005	mbh
EAST text search	7/23/2006	mbh

Search Notes (continued)

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